

#### **DUAL - N-Channel MOSFET Tetrode**

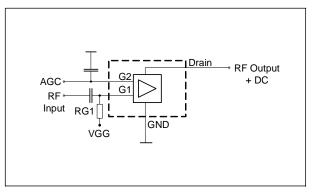
- Low noise gain controlled input stages of UHF-and VHF - tuners with 3V up to 5V supply voltage
- Integrated gate protection diodes
- Low noise figure
- High gain, high forward transadmittance
- Improved cross modulation at gain reduction
- · Biasing network partially integrated
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101





#### **BG5130R**





### ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Package	Pin Configuration						Marking
BG5130R	SOT363	1=G1*	2=S	3=D*	4=D**	5=G2	6=G1**	KYs

1

2007-06-01

<sup>\*</sup> For amp. A; \*\* for amp. B



## **Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	V <sub>DS</sub>	8	V
Continuous drain current	I <sub>D</sub>	25	mA
Gate 1/ gate 2-source current	± <i>I</i> <sub>G1/2SM</sub>	1	
Gate 1/ gate 2-source voltage	$\pm V_{\rm G1/G2S}$	6	V
Total power dissipation	P <sub>tot</sub>	200	mW
<i>T</i> <sub>S</sub> ≤ 78 °C			
Storage temperature	T <sub>stg</sub>	-55 150	$\mathcal C$
Channel temperature	$T_{ch}$	150	

## **Thermal Resistance**

Parameter	Symbol	Value	Unit
Channel - soldering point <sup>1)</sup>	R <sub>thchs</sub>	≤ 280	K/W

 $<sup>^{\</sup>rm 1} {\rm For}$  calculation of  $R_{\rm thJA}$  please refer to Application Note Thermal Resistance



**Electrical Characteristics** at  $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics	,			,	
Drain-source breakdown voltage	V <sub>(BR)DS</sub>	12	-	-	V
$I_{D} = 1 \ \mu A, \ V_{G1S} = 0 \ , \ V_{G2S} = 0$					
Gate1-source breakdown voltage	+V <sub>(BR)G1SS</sub>	6	-	15	
$+I_{G1S} = 10 \text{ mA}, V_{G2S} = 0, V_{DS} = 0$					
Gate2-source breakdown voltage	+V <sub>(BR)G2SS</sub>	6	-	15	
$+I_{G2S} = 10 \text{ mA}, V_{G1S} = 0, V_{DS} = 0$					
Gate1-source leakage current	+ <i>I</i> <sub>G1SS</sub>	-	-	50	nA
$V_{G1S} = 6 \text{ V}, \ V_{G2S} = 0$					
Gate2-source leakage current	+ <i>I</i> <sub>G2SS</sub>	-	-	50	
$V_{\rm G2S} = 6 \text{ V}, \ V_{\rm G1S} = 0 \ , \ V_{\rm DS} = 0$					
Drain current	I <sub>DSS</sub>	-	-	100	
$V_{\text{DS}} = 3 \text{ V}, \ V_{\text{G1S}} = 0 , \ V_{\text{G2S}} = 3 \text{ V}$					
Drain-source current	I <sub>DSX</sub>	-	10	-	mA
$V_{DS} = 3 \text{ V}, V_{G2S} = 3 \text{ V}, R_{G1} = 100 \text{ k}\Omega$					
Gate1-source pinch-off voltage	V <sub>G1S(p)</sub>	-	0.6	-	V
$V_{DS} = 3 \text{ V}, \ V_{G2S} = 3 \text{ V}, \ I_{D} = 20 \mu\text{A}$					
Gate2-source pinch-off voltage	V <sub>G2S(p)</sub>	-	0.7	-	
$V_{\rm DS} = 3 \ {\rm V}, \ V_{\rm G1S} = 3 \ {\rm V}, \ I_{\rm D} = 20 \ \mu {\rm A}$					

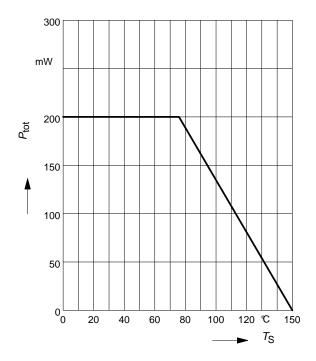


**Electrical Characteristics** at  $T_A = 25$ °C, unless otherwise specified

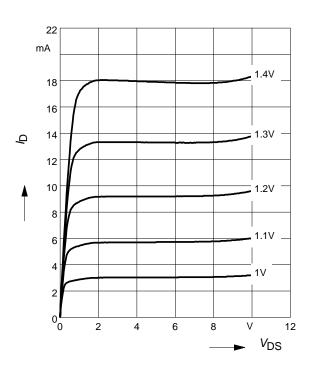
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics - (verified by random sampling	ng)	•	•		•
Forward transconductance	g <sub>fs</sub>	-	41	-	mS
$V_{DS} = 3 \text{ V}, \ V_{G2S} = 3 \text{ V}$					
Gate1 input capacitance	C <sub>g1ss</sub>	-	2.7	-	pF
$V_{DS} = 3 \text{ V}, V_{G2S} = 3 \text{ V}, f = 10 \text{ MHz}$					
Output capacitance	C <sub>dss</sub>	-	1.6	-	
$V_{DS} = 3 \text{ V}, V_{G2S} = 3 \text{ V}, f = 10 \text{ MHz}$					
Power gain	$G_{p}$				dB
$V_{DS} = 3 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 3 \text{ V},$					
f = 800 MHz		-	24	-	
$V_{DS} = 3 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 3 \text{ V},$					
f = 45  MHz		-	35	-	
Noise figure	F				dB
$V_{DS} = 3 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 3 \text{ V},$					
f = 800 MHz		-	1.3	-	
$V_{DS} = 3 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 3 \text{ V},$					
f = 45  MHz		-	1	-	
Gain control range	$\Delta G_{p}$	45	-	-	
$V_{DS} = 3 \text{ V}, V_{G2S} = 30 \text{ V}, f = 800 \text{ MHz}$	-				
Cross-modulation $k=1\%$ , $f_W=50MHz$ , $f_{unw}=60MHz$	$X_{\text{mod}}$				dB
AGC = 0		90	94	-	
AGC = 10  dB		-	92	-	
AGC = 40  dB		96	98	-	



## Total power dissipation $P_{tot} = f(T_S)$

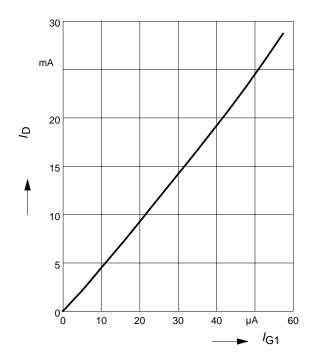


Output characteristics  $I_D = f(V_{DS})$ 



## **Drain current** $I_D = f(I_{G1})$

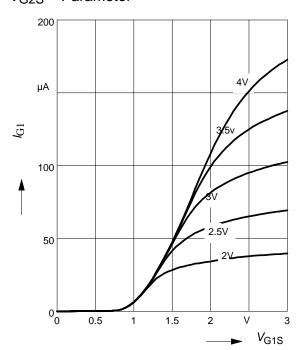
$$V_{\rm G2S} = 3V$$



# Gate 1 current $I_{G1} = f(V_{G1S})$

$$V_{DS} = 3V$$

$$V_{\rm G2S}$$
 = Parameter

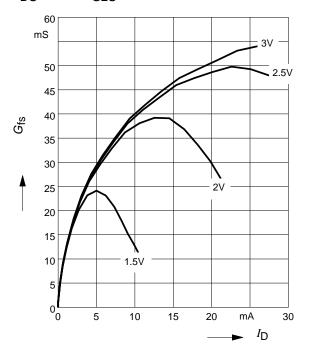


5 2007-06-01



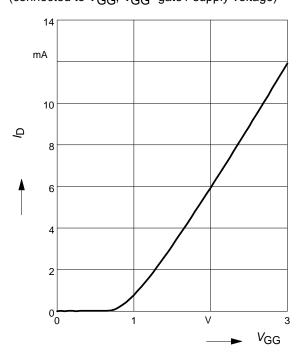
#### **Gate 1 forward transconductance**

$$g_{fS} = f(I_D)$$
  
 $V_{DS} = 3V, V_{G2S} = Parameter$ 



# **Drain current** $I_D = f(V_{GG})$

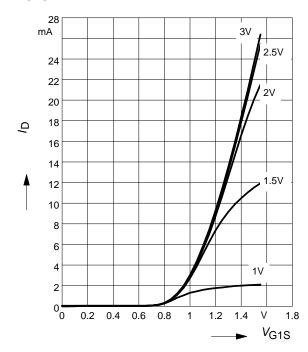
$$V_{\rm DS}$$
 = 3V,  $V_{\rm G2S}$  = 3V,  $R_{\rm G1}$  = 68k $\Omega$  (connected to  $V_{\rm GG}$ ,  $V_{\rm GG}$ =gate1 supply voltage)



## **Drain current** $I_D = f(V_{G1S})$

$$V_{DS} = 3V$$

$$V_{G2S}$$
 = Parameter

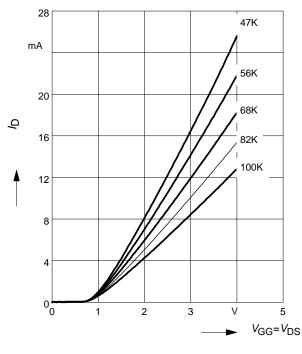


## **Drain current** $I_D = f(V_{GG})$

$$V_{G2S} = 3V$$

6

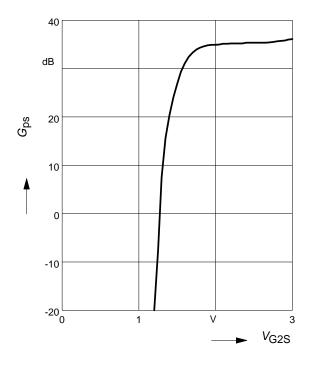
$$R_{G1}$$
 = Parameter in  $k\Omega$ 





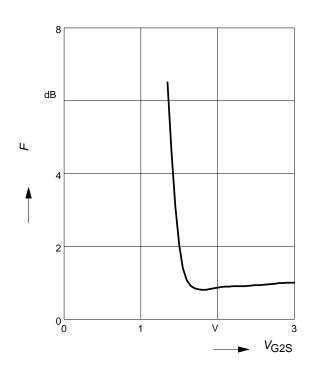
# Power gain $G_{ps} = f(V_{G2S})$

*f* = 45 MHz



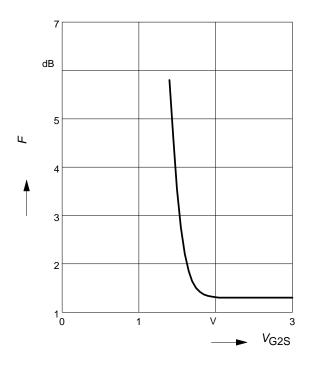
# Noise figure $F = f(V_{G2S})$

f = 45 MHz



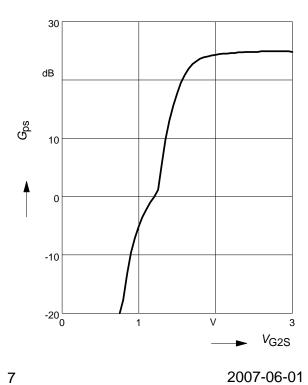
## Noise figure $F = f(V_{G2S})$

f = 800 MHz



# Power gain $G_{ps} = f(V_{G2S})$

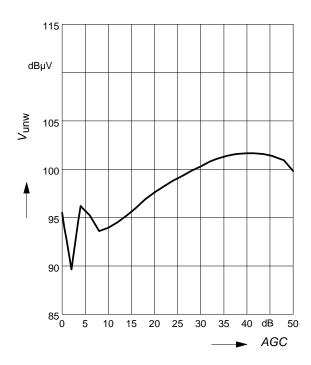
f = 800 GHz





# **Crossmodulation** $V_{unw} = (AGC)$

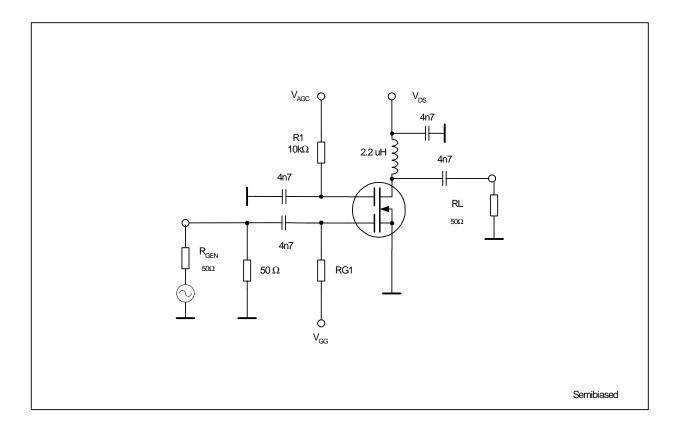
$$V_{\mathrm{DS}} = 3 \; \mathrm{V}, \; R_{\mathrm{g1}} = 68 \; \mathrm{k}\Omega$$



8 2007-06-01

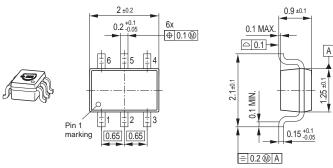


## **Crossmodulation test circuit**

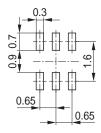




### Package Outline

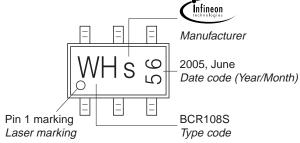


#### Foot Print



## Marking Layout (Example)

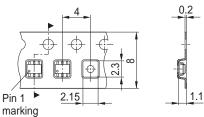
Small variations in positioning of Date code, Type code and Manufacture are possible.



### Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel

For symmetric types no defined Pin 1 orientation in reel.





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